## Search Notes



Application/Control No.	Applicant(s)/Patent Under Reexamination

10767468 HAN, HEE-CHUL

Examiner

Reyes, Mariela D

Art Unit

2167

## **SEARCHED**

	Class	Subclass	Date	Examiner	
	707	4	12/8/2006	MR	

## **SEARCH NOTES**

Search Notes	Date	Examiner
Inventor Search (Palm)	12/8/2006	MR
East Search	12/8/2006	MR
NPL Search (Google, TIVO)	12/9/2006	MR

## INTERFERENCE SEARCH

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Class	Subclass	Date	Examiner